onsemi

MOSFET – Power, N-Channel, Automotive, SUPERFET[®] III, Easy-Drive

650 V, 25 mΩ NVCR8LS025N65S3A

Features

- Typical $R_{DS(on)}$ = 19.9 m Ω at V_{GS} = 10 V
- Typical $Q_{g(tot)} = 236 \text{ nC}$ at $V_{GS} = 10 \text{ V}$
- AEC-Q101 Qualified
- RoHS Compliant

DIMENSION (µm)

Die Size	10830 x 7610
Die Size (Sawn)	10810 ±30 x 7590 ±30
Source Attach Area	(10155 x 3346) x 2
Gate Attach Area	406 x 618
Die Thickness	203.2 ± 25.4

Gate and Source : AlSiCu Drain : Ti–NiV–Ag (back side of die) Passivation : SiN Wafer Diameter : 8 inch Wafer sawn on UV Tape Bad dice identified in Inking Gross Die Count : 296

ORDERING INFORMATION

Device	Package
NVCR8LS025N65S3A	Wafer Sawn on Foil

RECOMMENDED STORAGE CONDITIONS

Temperature	22 to 28°C
RH	40% to 66%

ELECTRICAL CHARACTERISTICS

The Chip is 100% Probed to Meet the Conditions and Limits Specified at T_J = 25°C

Symbol	Parameter	Condition	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$	650	-	-	V
I _{DSS}	Drain to Source Leakage Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μA
I _{GSS}	Gate to Source Leakage Current	V_{GS} = +30 / -20 V, V_{DS} = 0 V	-	-	±100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 3 \text{ mA}$	2.5	-	4.5	V
*R _{DS(on)}	Bare Die Drain to Source On Resistance	I _D = 37.5 A, V _{GS} = 10 V	-	19.9	25	mΩ
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 37.5 V			1.2	V

*Accurate RDS(on) test at die level is not feasible for this thin die as limited by the test contact precision attainable in a die form. The max RDS(on) specification is defined from the historical performance of the die in package but is not guaranteed by test in production. The die RDS(on) performance depends on the Source wire/ribbon bonding layout.

ABSOLUTE MAXIMUM RATINGS

in Reference to the NVHL025N65S3 electrical data in TO-247-3LD (T_J = 25°C unless otherwise noted)

Symbol	Parameter		Ratings	Unit	
V _{DSS}	Drain to Source Voltage		650	V	
V _{GS}	Gate to Source Voltage	DC Positive	30	V	
		AC Positive, (f > 1Hz)	30	V	
		AC Negative, (f > 1Hz)	-20	V	
I _D	Continuous Drain Current $T_{\rm C} = 25^{\circ}{\rm C}$		75	А	
		$T_{\rm C} = 100^{\circ} \rm C$	65.8	А	
I _{DM}	Pulsed Drain Current	Pulsed (Note 1)	300	А	
E _{AS}	Single Pulse Avalanche Energy (Note 2)		2025	mJ	
E _{AR}	Repetitive Avalanche (Note 1)		5.95	mJ	
dv/dt	MOSFET dv/dt		100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)		20	V/ns	
PD	Power Dissipation $R_{\theta JC}$ $T_C = 25^{\circ}C$		595	W	
T _{J,} T _{STG}	Operating and Storage Temperature		–55 to +150	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Repetitive rating: pulse-width limited by maximum junction temperature. 2. $I_{AS} = 15 \text{ A}, R_G = 25 \Omega$, Starting $T_J = 25^{\circ}\text{C}$. 3. $I_{SD} < 75 \text{ A}, \text{ di/dt} \le 200 \text{ A/ms}, \text{VDD} \le \text{BVDSS}$, starting $T_J = 25^{\circ}\text{C}$

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
R _{θJ C} Thermal Resistance, Junction to Case, Max		0.21	°C/W
R _{θJ A}	Thermal Resistance, Junction to Ambient, Max	40	°C/W

ELECTRICAL CHARACTERISTICS

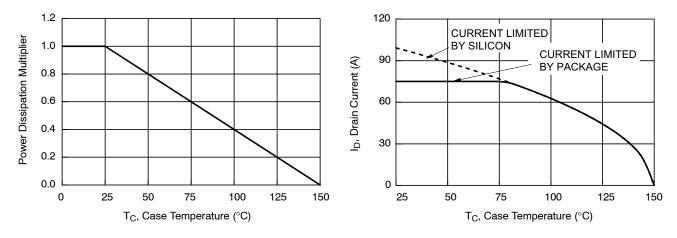
in Reference to the NVHL025N65S3 electrical data in TO-247-3LD (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Conditions		Тур.	Max.	Unit
OFF CHA	RACTERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	650	-	-	V
I _{DSS}	Drain to Source Leakage Current	V_{DS} = 650 V, V_{GS} = 0 V, T_{J} = 25°C		-	1	μΑ
		V_{DS} = 520 V, V_{GS} = 0 V, T_{J} = 125°C	-	7.92	-	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = +30 V	-	-	+100	nA
		V _{GS} = -20 V			-100	nA
ON CHAF	ACTERISTICS	-	-	-	-	-
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 3.0$ mA	2.5		4.5	V
R _{DS(on)}	Drain to Source On-Resistance	$I_D = 37.5 \text{ A}, \qquad T_J = 25^{\circ}\text{C}$	-	19.9	25	mΩ
		$V_{GS} = 10 \text{ V}$ $T_J = 100^{\circ}\text{C}$	-	34.6	-	mΩ
9 _{FS}	Forward Transconductance	V _{DS} = 20 V, I _D = 75 A		78.5		S
DYNAMIC	CHARACTERISTICS					
C _{iss}	Input Capacitance	$V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V},$	-	7330	-	pF
C _{oss}	Output Capacitance	f = 1 MHz	-	197	-	pF
C _{rss}	Reverse Transfer Capacitance		-	33.6	-	pF
C _{oss(eff.)}	Effective Output Capacitance	$V_{DS} = 0 V$ to 400 V, $V_{GS} = 0 V$		2062		pF
Coss(er.)	Energy Related Output Capacitance	$V_{DS} = 0 V$ to 400 V, $V_{GS} = 0 V$		285		pF
Q _{g(ToT)}	Total Gate Charge	V_{GS} = 10 V, V_{DS} = 400 V $_{\!\!,}$ I_D = 75 A	-	236	-	nC
Q _{gs}	Gate to Source Gate Charge	(Note 4)	-	59.3	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	97.3	-	nC
RG	Gate Resistance	f = 1 MHz	-	0.818	-	Ω
SWITCHI	NG CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V_{DD} = 400 V, I_D = 75 A, V_{GS} = 10 V,	-	43.3	-	ns
t _r	Rise Time	$R_{G} = 2 \Omega$	-	109	-	ns
t _{d(off)}	Turn-Off Delay Time	(Note 4)	-	120	-	ns
t _f	Fall Time		-	107	-	ns
DRAIN -	SOURCE DIODE CHARACTERISTICS					
I _S	Maximum Continuous Drain to Source Di	ode Forward Current			75	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current			300	Α
V _{SD}	Source to Drain Diode Voltage	V_{GS} = 0 V, I_{SD} = 37.5 A, V_{GS} = 0 V	-	-	1.2	V
t _{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_{SD} = 75 A, dI_{SD}/dt = 100 A/ μs	-	714	-	ns
	1			+	1	1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Essentially independent of operating temperature typical characteristics.

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TYPICAL CHARACTERISTICS



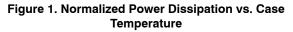


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

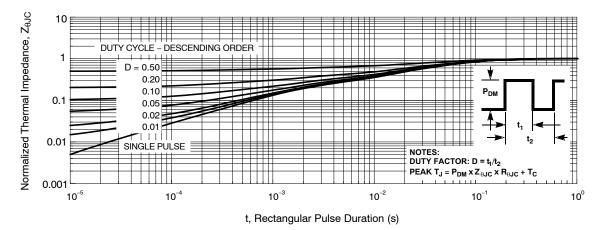
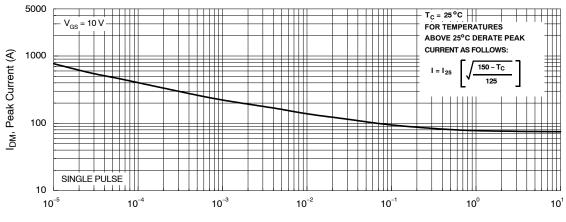


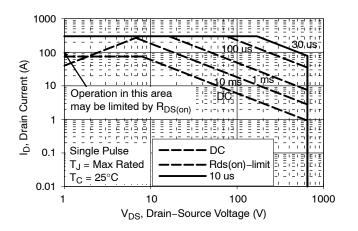
Figure 3. Normalized Maximum Transient Thermal Impedance

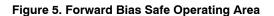


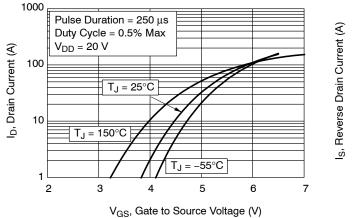
t, Rectangular Pulse Duration (s)

Figure 4. Peak Current Capability

TYPICAL CHARACTERISTICS (continued)









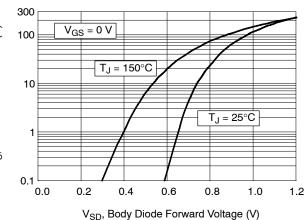


Figure 7. Forward Diode Characteristics

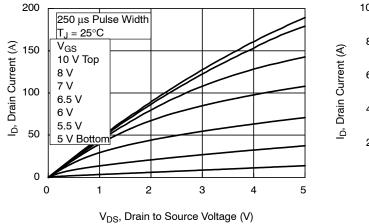


Figure 8. Saturation Characteristics

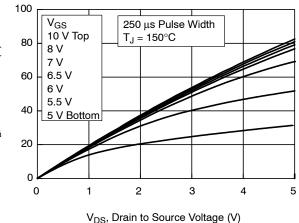
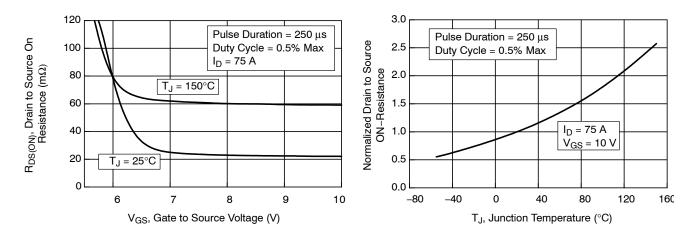


Figure 9. Saturation Characteristics

TYPICAL CHARACTERISTICS (continued)



1.2

1.1

1.0

0.9

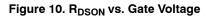
___80___

Breakdown Voltage

I_D = 10 mA

-40

0





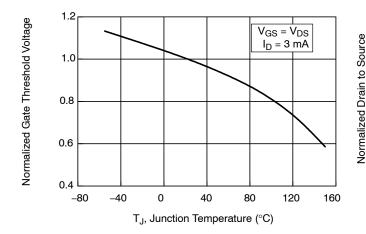
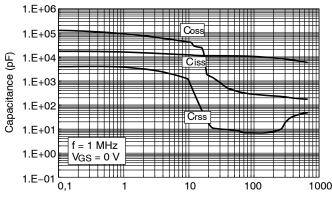


Figure 12. Normalized Gate Threshold Voltage vs. Temperature



V_{DS}, Drain to Source Voltage (V)

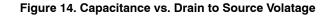


Figure 13. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

T_J, Junction Temperature (°C)

40

80

160

120

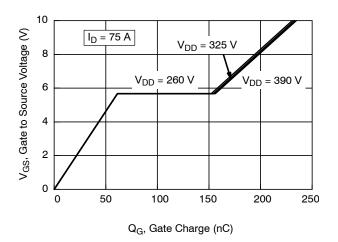


Figure 15. Gate Charge vs. Gate to Source Voltage

TYPICAL CHARACTERISTICS (continued)

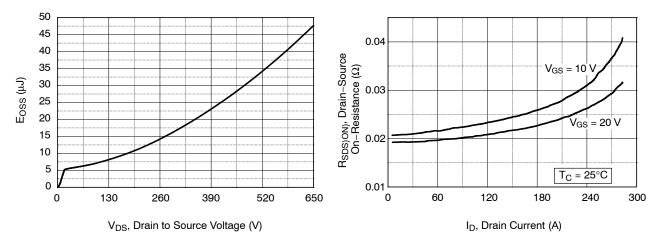


Figure 16. E_{OSS} vs. Drain to Source Voltage

Figure 17. On–Resistance Variation vs. Drain Current and Gate Voltage

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